Amp	FSCM77820				997	February, 1997 L-1142	
MOTHE	Insert stripped wire end into contact wire well. Strands should be visible in wire well inspection hole. Bottom contact and wire assembly in posi- tioner and close handles of crimp tool to complete crimp. Handles will not open unless full crimping cycle has been completed.	tact wire tom cont tool to c as been	nto con ple. Bot of crimp cycle h	e end i tion ha tindles	ped win I inspec close ha s full cri	Insert strip in wire wel tioner and o open unles	
DIA MIN		N	ω	4	5	SEL	
		28	26	24	22	AWG	
	MB & PC probe and not more than .038 for the DB & I/O probe.	an .038 f	nore th	nd not i	orobe ar	MB & PC p	
	winds. Assemble the MEEDEMEED Control control and MEEDEMEED post- tioner and place tool selector in correct setting for wire size. Selected wire size must not have an insulation diameter more than .062 for the	2-01 critic 1 correct lation di	lector ir an inst	ool se t have	place t	wire size n	
	Crimping Procedure: Using accepted industry procedures, strip wire end to be terminated 1/8 to 5/32 inches. Care should be taken not to nick wire strands. Accepted the Magazana and the taken has taken	es. Care	ing acce 32 inch	re: Us /8 to 5/	<sup>3</sup> rocedu nated 1,	Crimping F to be termi	
			insert.	=.			
DAUGHTER BO	Slide the holder forward and snap it onto the	e holder	lide the	ωo			
	Follow crimping procedure below. Slide the insert	rimping p	ollow ci	11			
.038	Slide holder over wire and then crimp contact.	ider over	nolder. Slide ho		st Probe	MB-PC Test Probe -	
	Then snap the insert contact assembly into the	ap the in	hen sn	· –			
	Slide the insert back over the wire and crimp contact on. Follow crimping procedure below	e insert on. Follo	slide the		st Probe	DB-I/O Test Probe -	
			C			assembly.	
	Board applications. We suggest that the user buy two kits if they are using connectors of two genders. The kits are not convertible after	ers. The	o gend seggus	of tw	nectors	Board app using com	
±.03	they are properly wired within a connector. It consists of a plastic holder, insert, and two contacts usable for either the Mother Board or Daughter	connecto for either	vithin a usable	wired v	roperly i two co	they are pr insert, and	
	This kit is specially designed for probing brush contacts to insure that	or probin	igned fo	ly des	special	This kit is	
TEST PROBE KIT 11-10400-22 For use with the AMPHENOL BRUSH CONTACT in LOW MATING FORCE ELECTRICAL CONNECTORS	TEST PRO For use with the AMI LOW MATING FORCE						

.125 ∟ DIA MAX

DAUGHTER BOARD - INPUT/OUTPUT TEST PROBE

-.675 MAX

+.072



- Amphenol Aerospace

AMPHENOL CORPORATION Amphenol Aerospace 40-60 Delaware Avenue Sidney, New York 13838-1395





